

Cite this: *Mater. Adv.*, 2020,  
1, 3507

# Tuning cesium–guanidinium in formamidinium tin triiodide perovskites with an ethylenediammonium additive for efficient and stable lead-free perovskite solar cells†

Gabriella A. Tosado, Erjin Zheng  and Qiuming Yu \*

Achieving efficient and stable tin-based perovskite solar cells remains challenging. In this work, we incorporate the ethylenediammonium diiodide (EDA<sub>2</sub>) additive into a cesium–guanidinium doped formamidinium tin triiodide perovskite with the composition of (CsGA)<sub>x</sub>FA<sub>1–2x</sub>SnI<sub>3</sub> + y% EDA<sub>2</sub>. This new perovskite utilizes the strong hydrogen bonding of the guanidinium cation and the lattice strain relaxation of the small cesium cation as well as the hollowing and passivation effects of the EDA<sub>2</sub> additive. The EDA<sub>2</sub> additive not only yields pinhole-free cubic phase perovskite films but also decreases both shallow and deep trap states in the perovskite films. These effects are pronounced with the increase of substitution of the pair of GA<sup>+</sup> and Cs<sup>+</sup>. The new perovskites are deployed in inverted planar solar cells. A maximum power conversion efficiency (PCE) of 5.01% is achieved with the (CsGA)<sub>0.15</sub>FA<sub>0.70</sub>SnI<sub>3</sub> + 0% EDA<sub>2</sub> device but the device degrades after storage in a nitrogen-filled glove box for 30 days. Both performance and stability are improved with the addition of EDA<sub>2</sub>. A maximum PCE of 5.72% is achieved with the (CsGA)<sub>0.15</sub>FA<sub>0.70</sub>SnI<sub>3</sub> + 1.0% EDA<sub>2</sub> device. The (CsGA)<sub>0.15</sub>FA<sub>0.70</sub>SnI<sub>3</sub> + 1.5% EDA<sub>2</sub> devices exhibit a maximum PCE of 5.69% and the performance is further increased to 6.39% after storage in a nitrogen-filled glove box for 4 days; 70% of the initial PCE is retained after 45 days. This study demonstrates the benefit of tuning cation sizes and introducing divalent cations to integrate stabilizing factors into pure Sn perovskites, creating new routes for efficient and stable lead-free perovskite solar cells.

Received 18th July 2020,  
Accepted 1st September 2020

DOI: 10.1039/d0ma00520g

rsc.li/materials-advances

## Introduction

Perovskite solar cells (PVSCs) have progressed rapidly in recent years. With the record power conversion efficiency (PCE) reaching 25.2%<sup>1</sup> and the potential for cost effective roll-to-roll printing capabilities, PVSCs are well positioned to encourage a transition to a clean energy economy. However, the toxicity of lead-based perovskite materials and the low stability and poor performance of lead-free perovskite alternatives present a challenge towards commercialization of perovskite technologies. Tin-based perovskites have been investigated as low-toxic alternatives to lead-based perovskites because tin has a comparable ionic radius (Sn<sup>2+</sup>, 1.15 Å and Pb<sup>2+</sup>, 1.19 Å)<sup>2</sup> and is also a group 14 metal, allowing Sn to maintain the crucial MX<sub>6</sub> octahedron.<sup>3</sup> Tin-based perovskites have certain intrinsic advantages over lead-based perovskites for photovoltaic devices such as a more favorable, comparably smaller bandgap, resulting in a higher Shockley–Queisser limit,

and a more rapid charge carrier mobility.<sup>4,5</sup> Unfortunately, the main drawback of pure Sn perovskites is an oxidation reaction that hinders photovoltaic performance. Tin-containing PVSCs have been shown to degrade from the oxidation of Sn<sup>2+</sup> to the more thermodynamically favored Sn<sup>4+</sup>, even in inert atmospheres, due to the small activation energy for the oxidation reaction.<sup>6,7</sup> The high levels of self-p-doping caused by Sn<sup>4+</sup> create a high defect density, also resulting in a low open-circuit voltage,  $V_{oc}$ .<sup>8</sup>

One strategy for improving the performance and stability of tin-based PVSCs has been focusing on A-site cation mixtures. Single A-site cation pure Sn perovskites, such as cesium tin triiodide (CsSnI<sub>3</sub>), methylammonium tin triiodide (MASnI<sub>3</sub>), and formamidinium tin triiodide (FASnI<sub>3</sub>), have been thoroughly explored in previous studies.<sup>9</sup> Although CsSnI<sub>3</sub> was the first explored active layer for pure Sn PVSCs, it has been plagued with a low PCE and  $V_{oc}$  because of its small tolerance factor, creating an orthorhombic perovskite phase.<sup>10,11</sup> MASnI<sub>3</sub> PVSCs demonstrated promising performance with a PCE of 6%. However, the devices were unstable and had poor reproducibility because of poor film morphology and Sn oxidation.<sup>12,13</sup> FASnI<sub>3</sub> was hypothesized to be more stable against oxidation because of increased hydrogen bonding and a lower dipole moment, allowing it to

Department of Chemical Engineering, University of Washington, Seattle, WA 98195, USA. E-mail: qyu@u.washington.edu

† Electronic supplementary information (ESI) available. See DOI: 10.1039/d0ma00520g



better rotate in the octahedral cage and interact with the halides.<sup>9,14</sup>

Recently, another organic cation has been demonstrated to further protect Sn against oxidation.<sup>15</sup> Guanidinium ( $\text{GA}^+$ ) cations have been used in Sn based PVSCs to improve performance and stability under ambient conditions. Due to the larger ionic radius of  $\text{GA}^+$  ( $r = 2.78 \text{ \AA}$ ) compared with  $\text{FA}^+$  ( $r = 2.53 \text{ \AA}$ ) and  $\text{MA}^+$  ( $r = 1.80 \text{ \AA}$ ), density functional theory (DFT) calculations predict that cubic-phase  $\text{GASnI}_3$  will have a shorter hydrogen bonding length and stronger interactions with the  $\text{SnI}_6$  octahedron.<sup>16</sup> The higher amounts of bonded amines create a symmetrical structure in  $\text{GA}^+$  and a zero electric dipole moment, unlike  $\text{FA}^+$  and  $\text{MA}^+$ , allowing for freer rotation of  $\text{GA}^+$  in the  $\text{SnI}_6$  framework. The high hydrogen bonding capability and free rotation enable  $\text{GA}^+$  to effectively passivate under-coordinated iodide ions, resulting in longer carrier lifetimes and an increased  $V_{\text{oc}}$  because of the reduced recombination centers.<sup>17</sup> The capability of passivating under-coordinated iodide ions is particularly important for pure Sn perovskites because iodide vacancies induce the oxidation of  $\text{Sn}^{2+}$  to  $\text{Sn}^{4+}$ .<sup>7</sup> In addition, the incorporation of  $\text{GA}^+$  into  $\text{FASnI}_3$  reduces the tendency of phase segregation because of the multiple hydrogen bonding sites. Therefore,  $\text{GA}^+$  is an excellent candidate for stabilizing mixed A-site Sn based perovskites. However, simply incorporating  $\text{GA}^+$  into  $\text{GA}_{0.20}\text{FA}_{0.80}\text{SnI}_3$  perovskites yielded very low efficiency PVSCs with a PCE of 0.5% even though extra  $\text{SnF}_2$  was added as a reducing agent.<sup>15</sup> This could be due to the increased local lattice strain created by introducing such a large organic cation. The increased local lattice strain has been theorized to be due to increasing point defect formation to relieve the strain.<sup>18</sup> The increased point defects could be the sites for oxidation and/or trap centers, affecting the performance of Sn-based PVSCs significantly.

One method that has been shown to “hollow” out three-dimensional (3D) perovskites and reduce lattice strain is introducing ethylenediammonium diiodide ( $\text{EDAI}_2$ ).  $\text{EDAI}_2$  has been explored as an A-site cation in 3D  $\text{FASnI}_3$  and  $\text{MASnI}_3$  perovskites.<sup>19</sup> Shallow trap states are localized in the crystal bulk structure and are located near the conduction or valence band edges. Deep trap states involve grain boundary defects and are located closer to the middle of the band gap.<sup>20,21</sup> The incorporation of such a large divalent cation results in not only the occupation of A-sites, but also the removal of B- and X-sites, reducing both bulk defects and shallow trap states. In addition, the divalent cations terminate crystal surfaces, reducing deep trap states at grain boundaries. The performance of  $\text{FASnI}_3$  PVSCs improved from a PCE of 1.40% without  $\text{EDAI}_2$  to 7.14% with 10%  $\text{EDAI}_2$  and the efficiency was maintained after 1000 h for encapsulated devices.<sup>19</sup> It has been demonstrated that incorporating  $\text{EDAI}_2$  into  $\text{MASnI}_3$  lowers the electron trap state density and increases the carrier lifetime, which leads to an improvement of the device performance from a PCE of 0.17% without  $\text{EDAI}_2$  to 5.49% with 15%  $\text{EDAI}_2$ .<sup>22</sup> The significant improvement of device performance and stability is attributed to the occupation of point defects inside the crystalline grains and the passivation of defects at grain boundaries by  $\text{EDAI}_2$

cations, decreasing both shallow and deep trap states. Adding  $\text{EDAI}_2$  to  $\text{FA}_{0.80}\text{GA}_{0.20}\text{SnI}_3$  greatly enhanced the device performance from a PCE of 0.5% without  $\text{EDAI}_2$  to the maximum PCE of 7.4% with 1%  $\text{EDAI}_2$ .<sup>23</sup> More interestingly, the PCE even increased to a maximum of 8.9% after the device was stored in a glove box for over 1400 h. The fascinating behavior is due to the slow crystal relaxation and surface passivation induced by  $\text{EDAI}_2$ . Another method of reducing lattice strain caused by a large organic cation is the addition of a smaller counter ion, such as  $\text{Cs}^+$ . A small cation can fill point defects, reducing shallow trap states and protecting the sites from oxidation.<sup>18</sup> Using  $\text{Cs}^+$  to counterbalance the large  $\text{GA}^+$  cation in a  $\text{FASnI}_3$  perovskite should allow the retention of the stabilizing effects of  $\text{GA}^+$  while reducing the local lattice strain, thus improving the performance of the corresponding devices.

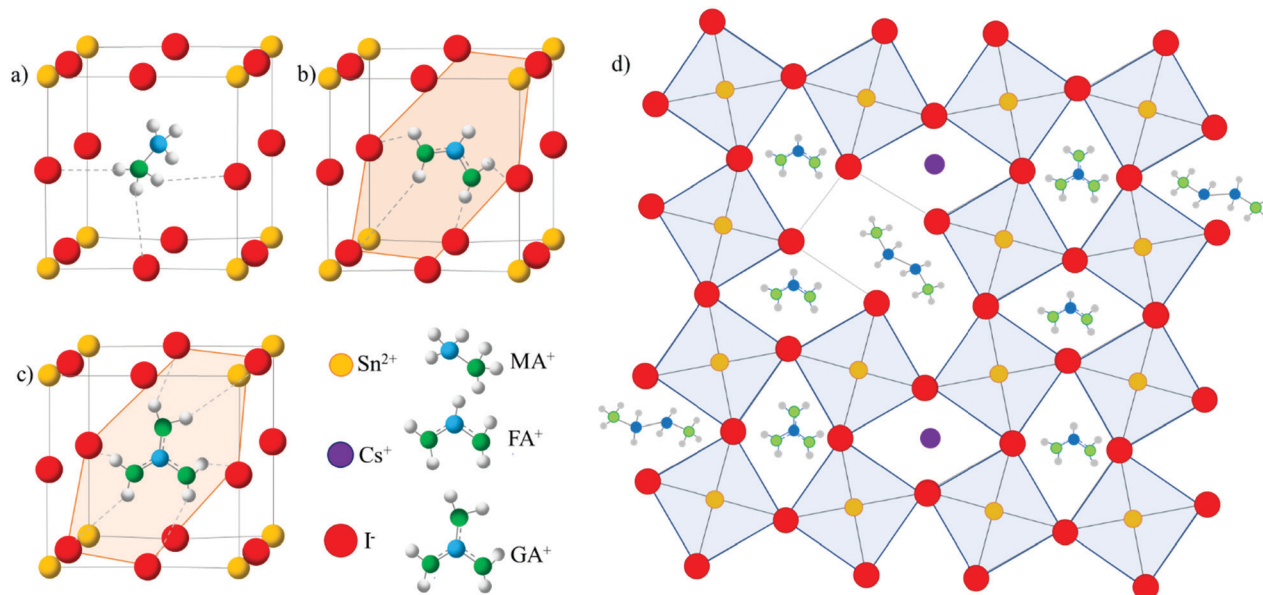
In this study, we implement both  $\text{GA}^+$  and  $\text{Cs}^+$  cations into the  $\text{FASnI}_3$  crystal structure to introduce more hydrogen bonding and to reduce local strains, respectively, within the perovskite crystals (Fig. 1a–d). We further incorporate  $\text{EDAI}_2$  to replace some octahedral sites inside the crystal and to passivate defects at the grain boundaries (Fig. 1d) to relax lattice strains and reduce oxidation and trap states. We successfully synthesize densely packed, lead-free polycrystalline  $(\text{CsGA})_x\text{FA}_{1-2x}\text{SnI}_3$  films with  $\text{EDAI}_2$ . To reduce transport layer impacts on Sn oxidation, we use the inverted device structure of indium tin oxide (ITO)/poly(3,4-ethylenedioxythiophene):polystyrene sulfonate (PEDOT:PSS)/perovskite/[6,6]-phenyl-C<sub>60</sub>-butyric acid methyl ester ( $\text{PC}_{60}\text{BM}$ )/2,9-dimethyl-7,7-diphenyl-1,10-phenanthroline (BCP)/Ag. The substitution of  $\text{FA}^+$  with the pair of  $\text{Cs}^+$  and  $\text{GA}^+$  leads to a  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  device with a maximum PCE of 5.01%, much higher than that obtained simply by the incorporation of  $\text{GA}^+$  in  $\text{GA}_{0.20}\text{FA}_{0.80}\text{SnI}_3$ , but the device loses the diode behaviour after storage in a nitrogen-filled glove box for 30 days. With the  $\text{EDAI}_2$  additive, freshly made  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  with 1%  $\text{EDAI}_2$  devices exhibit a record maximum PCE of 5.72%. The UV-Vis absorption and ultraviolet photoelectron spectroscopy (UPS) results show that the addition of  $\text{EDAI}_2$  reduces the amount of trap states in perovskite thin films, improving the short-circuit current,  $J_{\text{sc}}$ , and the open-circuit voltage,  $V_{\text{oc}}$ . Devices made with  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  and 1.5%  $\text{EDAI}_2$  exhibit a maximum PCE of 5.69% and the maximum PCE increases to 6.39% after storage in a nitrogen-filled glove box for 4 days; the device retains 70% of the initial PCE after 45 days. Thin film trap state reduction and device stability improvement highlight the importance of  $\text{EDAI}_2$  as a mitigating agent. Tuning cation sizes and integrating divalent cations create new routes for developing efficient and stable pure Sn PVSCs.

## Experimental

### Materials

Tin(II) iodide ( $\text{SnI}_2$ , 99.99%), cesium iodide ( $\text{CsI}$ , 99.999%), chloroform ( $\geq 99.99\%$ ), chlorobenzene (anhydrous, 99.8%), *N,N*-dimethyl sulfoxide (DMSO, anhydrous,  $\geq 99.9\%$ ), 2-propanol and bathocuproine (BCP, 99.99%) were purchased





**Fig. 1**  $\text{SnI}_6$  inorganic framework highlighting N–H–I hydrogen bonding in (a)  $\text{MASnI}_3$ , (b)  $\text{FASnI}_3$ , and (c)  $\text{GASnI}_3$ . (d) Schematic illustration of the 3D  $(\text{CsGA})_x\text{FA}_{1-2x}\text{SnI}_3$  perovskite with the  $\text{EDAl}_2$  additive showing  $\text{EDA}^{2+}$  cations creating potential hollowing inside the crystal as well as passivating defects along the grain boundaries. Yellow, purple, red, grey, blue, and green spheres represent Sn, Cs, I, H, C, and N atoms, respectively, and octahedra are marked by blue squares.

from Sigma-Aldrich (St. Louis, Missouri) without further purification. Guanidinium iodide (GAI) and formamidinium iodide (FAI) were purchased from GreatCell Solar (Queanbeyan, Australia) while ethylenediammonium diiodide ( $\text{EDAl}_2$ ) was purchased from Millipore and used without further purification. [6,6]-Phenyl- $\text{C}_{61}$ -butyric acid methyl ester ( $\text{PC}_{60}\text{BM}$ ) (> 99.5%) was purchased from American Dye Solar (Quebec, Canada).

### Thin film fabrication

The perovskite precursor solutions were prepared in a  $\text{N}_2$  glove box by dissolving FAI and  $\text{SnI}_2$  at the corresponding molar ratios in pure DMSO with a total concentration of 2.0 M. 10 mol% excess  $\text{SnI}_2$  was added into the precursor solution to reduce vacancies. CsI, GAI, and  $\text{EDAl}_2$  were dissolved in separate vials of DMSO at a concentration of 1.5 M and added to the perovskite precursor to achieve the correct triple cation composition. For the  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  composition with 1%  $\text{EDAl}_2$ , for example, 0.1204 g of FAI and 0.4098 g of  $\text{SnI}_2$  were dissolved in 850  $\mu\text{l}$  of DMSO and stirred at 60 °C for 0.5 h. 100  $\mu\text{l}$  of the 1.5 M CsI solution and 100  $\mu\text{l}$  of the 1.5 M GAI solution were added to the precursor and stirred continuously at 60 °C for 0.5 h. 14  $\mu\text{l}$  of the 1.5 M  $\text{EDAl}_2$  solution was finally added to the precursor solution and stirred overnight at room temperature. The final precursor solution was then filtered through a 0.2  $\mu\text{m}$  PTFE filter before use. Plain glass was cut into 15 mm  $\times$  15 mm substrates, which were cleaned *via* ultrasonication for 15 min in detergent in Millipore deionized water, Millipore deionized water, acetone, and isopropanol in sequence. The substrates were treated with oxygen plasma at 100 W for 10 min. A 70  $\mu\text{l}$  drop of the precursor solution was spin-coated on a cleaned glass substrate at 500 rpm for 5 s,

1000 rpm for 15 s, and 4000 rpm for 40 s in a nitrogen glove box. 500  $\mu\text{l}$  of chlorobenzene anti-solvent was dripped *in situ* onto the substrate during the last 15 s of the third spin-coating step. The perovskite films were then thermally annealed at 110 °C for 10 min.

### Film characterization

Scanning electron microscopy (SEM) images were acquired using an FEI Sirion SEM operated at 15 kV to analyze the surface morphology. Two-dimensional X-ray diffraction (XRD) patterns were collected with a Bruker GADDS D8 Focus Powder Discover diffractometer using  $\text{Cu K}\alpha$  radiation ( $\lambda = 1.5419 \text{ \AA}$ ) and the data were processed using the EVA package provided by Bruker AXS to investigate the crystalline structures of perovskite thin films. Ultraviolet-visible (UV-Vis) absorption spectra were collected using a Varian Cary 5000 UV-Vis-NIR spectrophotometer. Photoluminescence (PL) spectra were obtained with a Horiba HR-800 with 532 nm laser excitation. Ultraviolet photoelectron spectroscopy (UPS) measurements were conducted using a Kratos AXIS Ultra DLD spectrometer to investigate the valence band structures of perovskite thin films. A He discharge lamp source (Kratos) at an excitation energy of 21.2 eV was used in combination with a delay line detector at an electron pass energy of 5 eV. The UPS spectra for Au were acquired with a step size of 0.1 eV and a dwell time of 100 ms. The high-resolution UPS spectra and Fermi edge spectra were acquired with a step size of 0.01 eV and a dwell time of 100 ms.

### Device fabrication

ITO coated glass substrates (10  $\text{Ohm sq}^{-1}$  ITO, Colorado Concept Coatings LLC) were cut and cleaned as described





above. The PEDOT:PSS (AI 4083, Heraeus Clevious™) solution was filtered with a 0.45  $\mu\text{m}$  nylon filter. A 70  $\mu\text{l}$  drop of PEDOT:PSS was spin-coated on a cleaned ITO coated glass substrate at 5000 rpm for 60 s and annealed at 150  $^{\circ}\text{C}$  for 10 min in air. The substrates were transferred to a  $\text{N}_2$  glove box and the perovskite thin films were fabricated as described above. A PC<sub>60</sub>BM solution (15  $\text{mg ml}^{-1}$  in chloroform) was then spin-coated on the perovskite films at 4000 rpm for 60 s and dried without annealing. A BCP solution (0.5  $\text{mg ml}^{-1}$  in 2-propanol) was then spin-coated on the films at 4000 rpm for 60 s and dried without annealing. Finally, a mask with  $3.14 \times 10^{-6} \text{ m}^2$  area holes was placed on substrates that were loaded into a thermal evaporation chamber to thermally deposit 100 nm of silver as electrodes in a high vacuum evaporator ( $<1 \times 10^{-6}$  Torr). The resulting device structure is ITO/PEDOT:PSS/perovskite/PC<sub>60</sub>BM/BCP/Ag.

### Device performance tests

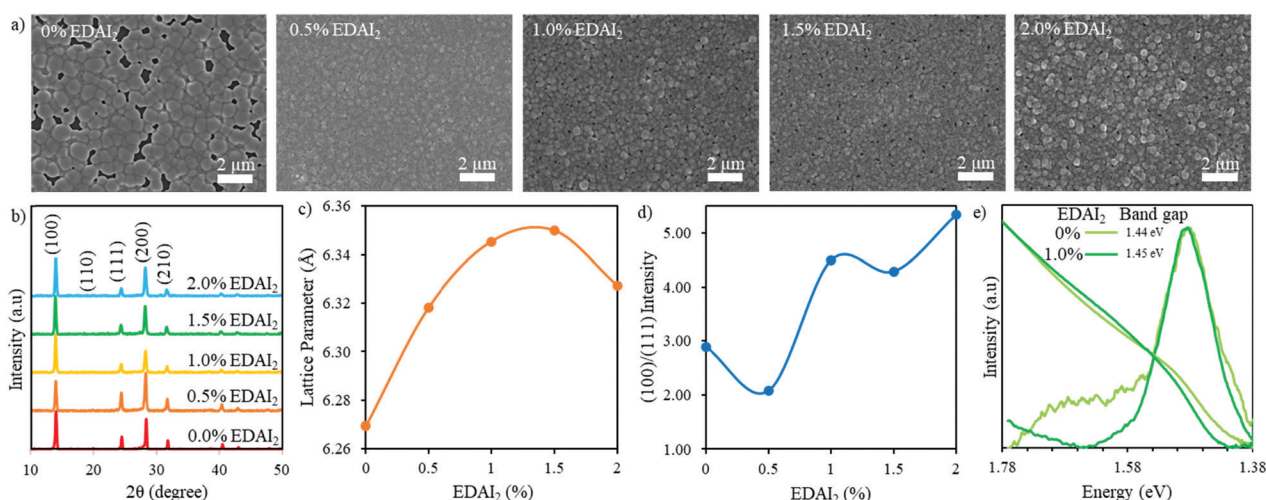
The photocurrent density–voltage ( $J$ – $V$ ) curves, light intensity dependent  $J$ – $V$  curves, and steady-state photocurrent measurements were conducted in a  $\text{N}_2$  glove box with a Keithley 2400 SourceMeter and a Solar Light Co. Xenon lamp (16S–300 W) and AM 1.5G filter. Before measurements, the light intensity was calibrated to 100  $\text{mW cm}^{-2}$  using a standardized National Renewable Energy Laboratory calibrated silicon solar cell.

## Results and discussion

A one-step solution process with the chlorobenzene anti-solvent was used to form the pure Sn perovskite films. All precursors (FAI,  $\text{SnI}_2$ , GAI, CsI, and  $\text{EDAI}_2$ ) were dissolved in pure DMSO to a total concentration of 2.0 M and spin-coated on ITO/glass substrates. 10 mol% excess  $\text{SnI}_2$  was added to suppress the

vacancies in the crystal lattice. All films were annealed at 110  $^{\circ}\text{C}$  for 10 min. The pure Sn perovskite films have the compositions of  $(\text{CsGA})_x\text{FA}_{1-2x}\text{SnI}_3 + y\% \text{EDAI}_2$ , where  $x = 0.05, 0.10, 0.15,$  and  $0.20$  and  $y = 0, 0.5, 1.0, 1.5,$  and  $2.0$ . To simplify further discussion, we implement a notation of  $(\text{CsGA})_x$ , where  $x$  is the percentage of cation added, to represent the various compositions. For example,  $(\text{CsGA})_5$  would represent  $(\text{CsGA})_{0.05}\text{FA}_{0.90}\text{SnI}_3$ . The anti-solvent wash with the highly non-polar chlorobenzene was performed while spin-coating to remove excess DMSO from  $\text{SnI}_2 \cdot 3\text{DMSO}$ . The removal of excess DMSO results in the formation of  $\text{A-SnI}_2 \cdot 2\text{DMSO}$  intermediates, allowing the slower removal of DMSO and growth of polycrystalline perovskite thin films upon annealing, thus minimizing pinholes. Although  $\text{SnF}_2$  has been used to minimize the oxidation of  $\text{Sn}^{2+}$  to  $\text{Sn}^{4+}$ , excess  $\text{SnF}_2$  has been shown to form separate phases and phase segregation on perovskite film surfaces or grain boundaries over time.<sup>14,24</sup> Excess  $\text{SnI}_2$  has been shown to be effective in preventing  $\text{Sn}^{2+}$  oxidation by both compensating and suppressing  $\text{Sn}^{2+}$  vacancies without having any adverse side effects on phase stability and phase segregation.<sup>25,26</sup> Previous research has argued that excess  $\text{SnI}_2$  may even be more effective than  $\text{SnF}_2$  as a reducing agent since  $\text{SnF}_2$  is hard to dissociate in films because of its low solubility and stability.<sup>27</sup> To minimize  $\text{SnF}_2$  assisted phase segregation, we use excess  $\text{SnI}_2$  plus  $\text{EDAI}_2$  to reduce  $\text{Sn}^{2+}$  oxidation.

Fig. 2a shows the scanning electron microscopy (SEM) images of the synthesized  $(\text{CsGA})_{15} + y\% \text{EDAI}_2$  perovskite thin films. Without the addition of  $\text{EDAI}_2$ ,  $(\text{CsGA})_{15}$  films contain flat, large grains and pinholes, which may be due to the presence of a few nuclei and a rapid crystal growth rate.<sup>28</sup>  $\text{EDAI}_2$  has been previously shown to act as a controlling agent and balance the kinetic processes between crystal growth and nucleation. The divalent nature of  $\text{EDAI}_2$  allows uniform nucleation and, in tandem with the slow crystal growth, forming



**Fig. 2** (a) SEM images and (b) XRD patterns of  $(\text{CsGA})_{15} + y\% \text{EDAI}_2$  perovskite thin films with  $y = 0, 0.5, 1.0, 1.5,$  and  $2.0$ . (c) The cubic lattice parameter and (d) the (100)/(111) peak intensity ratio of  $(\text{CsGA})_{15} + y\% \text{EDAI}_2$  as a function of percent  $\text{EDAI}_2$ . (e) PL spectra and normalized UV-Vis absorption spectra of  $(\text{CsGA})_{15}$  thin films with 0 and 1.0%  $\text{EDAI}_2$ . The optical band gaps are derived from the Tauc plots of  $(\text{CsGA})_{15}$  thin films with 0 and 1.0%  $\text{EDAI}_2$  in Fig. S6e (ESI†).





parameter decreases to 6.327 Å when compared to the peak value with 1.5% EDAl<sub>2</sub> but still shows a 0.93% increase compared to that with 0% EDAl<sub>2</sub> (Fig. 2c and Fig. S5, ESI†). Similar trends were shown for (CsGA)<sub>5</sub> and (CsGA)<sub>10</sub> films, except that the lattice parameter decreases with 1.5% EDAl<sub>2</sub> and then increases with 2.0% EDAl<sub>2</sub> for both (CsGA)<sub>5</sub> and (CsGA)<sub>10</sub> films (Fig. S1c, ESI†). It is noted that negative lattice parameter changes were observed for (CsGA)<sub>5</sub> with 1.5 and 2.0% EDAl<sub>2</sub> and (CsGA)<sub>10</sub> with 1.5% EDAl<sub>2</sub> (Fig. S5, ESI†). Another interesting trend is that the lattice parameter increases with increasing CsGA substitution in thin films with 0.5 and 1.0% EDAl<sub>2</sub> addition. For (CsGA)<sub>5</sub> films, the lattice parameter increases similarly by 0.14% from 6.291 Å without EDAl<sub>2</sub> to 6.300 Å with 0.5% and 1% EDAl<sub>2</sub>, while the corresponding increases are 0.57% and 0.71% from 6.274 Å without EDAl<sub>2</sub> to 6.31 Å with 0.5% EDAl<sub>2</sub> and 6.318 Å with 1% EDAl<sub>2</sub> for (CsGA)<sub>10</sub> films (Fig. S5, ESI†). The results indicate that EDAl<sup>2+</sup> ions are integrated into the crystal lattices, replacing octahedral sites in the perovskites and introducing a small “hollowing” effect, as illustrated in Fig. 1d. A stronger “hollowing” effect in the larger CsGA substitution films with the same small amount of EDAl<sub>2</sub> addition (0.5 and 1.0%) could be because the incorporation of a larger amount of small Cs<sup>+</sup> cations makes more A-site spaces to accommodate more EDAl<sup>2+</sup>, creating more hollow centers and expanding the crystal lattice. The decrease of the lattice parameter for both (CsGA)<sub>5</sub> and (CsGA)<sub>10</sub> films with 1.5% EDAl<sub>2</sub> could be due to expelling large GA<sup>+</sup> cations from the perovskite lattice and most EDAl<sup>2+</sup> being able to passivate or terminate, instead of hollow, the perovskite crystals. Although the lattice parameter for the (CsGA)<sub>15</sub> film with 2.0% EDAl<sub>2</sub> decreases compared to that of the film with 1.5% EDAl<sub>2</sub>, the lattice parameter is still larger than that of the film without EDAl<sub>2</sub>. This suggests that there might be an energy balance between hollowing crystal structures and terminating crystal surfaces with EDAl<sub>2</sub>. Nonetheless, the results of increased crystal orientation towards the (100) plane and the lattice parameter variations with the addition of EDAl<sub>2</sub> reveal that EDAl<sub>2</sub> can both create hollow centers inside crystals and passivate grain boundaries.

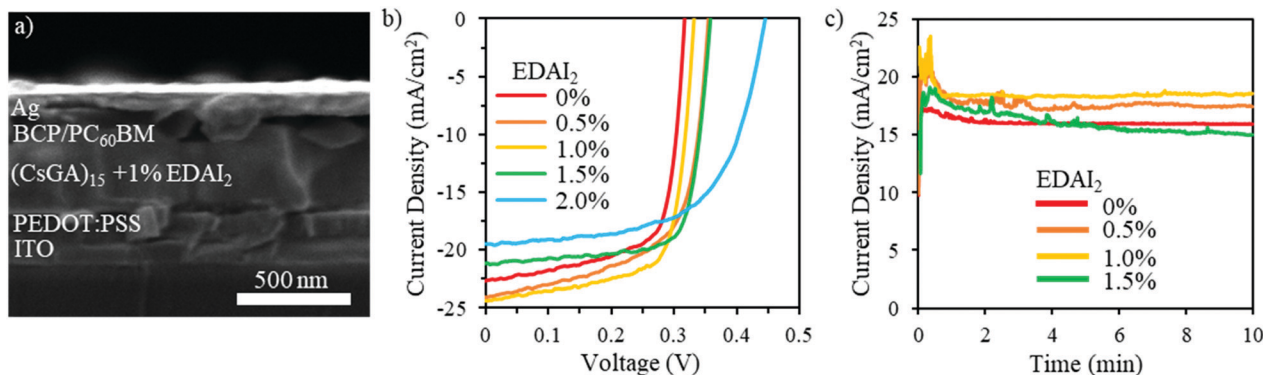
To investigate the impacts of both CsGA and EDAl<sub>2</sub> on the optical and electronic properties, we recorded the UV-Vis absorption and static photoluminescence (PL) spectra of (CsGA)<sub>5</sub>, (CsGA)<sub>10</sub> and (CsGA)<sub>15</sub> thin films. The UV-Vis and PL spectra of (CsGA)<sub>5</sub>, (CsGA)<sub>10</sub> and (CsGA)<sub>15</sub> thin films with 0 and 1% EDAl<sub>2</sub> addition are shown in Fig. 2e and Fig. S6 (ESI†). The optical band gaps derived from the Tauc plots in Fig. S6c–e (ESI†) for 0 and 1% EDAl<sub>2</sub> contents are 1.46 and 1.46 eV for (CsGA)<sub>5</sub>, 1.45 and 1.46 eV for (CsGA)<sub>10</sub>, and 1.44 and 1.45 eV for (CsGA)<sub>15</sub>, respectively. Without EDAl<sub>2</sub>, the band gap decreases slightly from 1.46 to 1.45 eV when increasing the CsGA substitution from 5 to 15%. The average cation radius and lattice parameter decrease for these films, as discussed above (Fig. 2c and Table S1, Fig. S1c, ESI†). In our previous work, we showed that the band gap of Cs<sub>x</sub>(MA<sub>0.17</sub>FA<sub>0.83</sub>)<sub>1-x</sub>Sn(I<sub>0.83</sub>Br<sub>0.17</sub>)<sub>3</sub> perovskites decreases with decreasing lattice parameter due to a smaller average cation radius.<sup>33</sup> Both A-site induced BX<sub>6</sub> octahedral tilting and B–X overlap on the conduction and valence band edges of perovskites influence these band gap trends.<sup>34</sup>

The correlation between the band gap decrease and the lattice parameter decrease for (CsGA)<sub>x</sub> without EDAl<sub>2</sub> reflects that the same mechanism is occurring, where the increased isotropic lattice constrictions and B–X overlap make the valence band maximum shift upwards more than the conduction band minimum.<sup>35</sup> For (CsGA)<sub>10</sub> and (CsGA)<sub>15</sub>, when 1% EDAl<sub>2</sub> is added, there is a 0.01 eV blue shift of band gaps because of the decreased isotropic lattice constrictions, decreasing the B–X overlap. This blue shift is also due to the larger and divalent nature of EDAl<sup>2+</sup> displacing B-site and X-site atoms, eliminating several B–X connections. These missing B–X connections decrease the orbital overlap of the remaining Sn–I bonds, narrowing the width of the valence band and conduction band.<sup>22,23</sup> In addition, the UV-Vis absorption cutoff edges are sharper and the PL peaks are narrower and stronger for (CsGA)<sub>10</sub> and (CsGA)<sub>15</sub> with 1.0% EDAl<sub>2</sub>. These phenomena are more obvious with increasing CsGA substitution and diminish for (CsGA)<sub>5</sub> films (Fig. 2e and Fig. S6, ESI†). Although there is still a difference in band gap with and without EDAl<sub>2</sub> for the (CsGA)<sub>5</sub> composition, the change is small enough that they are considered the same band gap within our measurement limitations. The opening of the band gap, sharpening of the UV-Vis absorption cutoff edge, and narrowing with increased intensity of the PL peak further suggest that the addition of EDAl<sub>2</sub> can reduce the trap states between band gaps by reducing point defects inside the crystals *via* the hollowing effect and by reducing surface defects *via* the passivation of grain boundaries. Moreover, a greater amount of CsGA substitution is crucial for integrating EDAl<sup>2+</sup> cations and utilizing their effect on decreasing trap states.

The (CsGA)<sub>x</sub> + y% EDAl<sub>2</sub> films were deployed as active layers in PVSCs with an inverted device structure of ITO/PEDOT:PSS/perovskite/PC<sub>60</sub>BM/BCP/Ag, which is illustrated in the cross-sectional SEM image shown in Fig. 3a. Solution processed PEDOT:PSS acts as the hole transport layer (HTL) while the spin-coated PC<sub>60</sub>BM acts as the electron transport layer (ETL) as well as reducing the surface roughness and passivating possible traps.<sup>36</sup> The solution processed BCP layer acts as a hole blocking layer (HBL) to increase charge separation and minimize recombination. Fig. 3b shows the photocurrent density–voltage (*J*–*V*) characteristics of the devices fabricated with (CsGA)<sub>15</sub> + y% EDAl<sub>2</sub> active layers with y = 0, 0.5, 1.0, 1.5 and 2.0. Detailed photovoltaic parameters are summarized in Table 1. The *J*–*V* characteristics and detailed photovoltaic parameters of the devices fabricated with (CsGA)<sub>5</sub> and (CsGA)<sub>10</sub> with 0–2.0% EDAl<sub>2</sub> are presented in Fig. S7 and Table S2 (ESI†). The devices containing the active layer (CsGA)<sub>15</sub> without EDAl<sub>2</sub> exhibit the maximum PCE of 5.01%, with the corresponding *V*<sub>oc</sub> of 0.32 V, *J*<sub>sc</sub> of 22.61 mA cm<sup>-2</sup>, and FF of 0.70. The maximum PCE of our (CsGA)<sub>15</sub> + 0% EDAl<sub>2</sub> devices is much higher than the 0.5% PCE of the devices with GA<sub>0.2</sub>FA<sub>0.8</sub>SnI<sub>3</sub> without EDAl<sub>2</sub>, particularly, the maximum *V*<sub>oc</sub> of 0.32 V *versus* the reported *V*<sub>oc</sub> of ~0.1 V.<sup>15</sup> Adding Cs<sup>+</sup> to balance the larger GA<sup>+</sup> cations could decrease shallow trap states *via* Cs<sup>+</sup> filling in defects, which increases *V*<sub>oc</sub> and improves *J*<sub>sc</sub> and FF, culminating in much better device performance. Adding 0.5 and 1.0% EDAl<sub>2</sub> increases the maximum PCE to 5.39% and 5.72% due to both







**Fig. 3** (a) Cross-sectional SEM image showing the  $(\text{CsGA})_{15} + 1.0\% \text{EDAl}_2$  PVSC with the following layers: ITO (200 nm)/PEDOT:PSS (50 nm)/perovskite (400 nm)/PC<sub>60</sub>BM/BCP/Ag (100 nm). (b) Photocurrent density–voltage ( $J$ – $V$ ) characteristics of the best performance PVSCs with the active layer containing  $(\text{CsGA})_{15} + y\% \text{EDAl}_2$  thin films with  $y = 0, 0.5, 1.0, 1.5,$  and  $2.0$  under AM 1.5G illumination scanned from  $-0.1$  to  $0.6$  V at a scan rate of  $0.01$  V  $\text{s}^{-1}$ . (c) Steady state photocurrent for the best performance PVSCs containing the active layers of  $(\text{CsGA})_{15}$  at the maximum power points with the voltages of  $0.274, 0.290, 0.272,$  and  $0.308$  V for  $0, 0.5, 1.0,$  and  $1.5\% \text{EDAl}_2$ , respectively.

**Table 1** Average photovoltaic parameters and the best performance device photovoltaic parameters in parentheses along with series resistance,  $R_s$ , and shunt resistance,  $R_{sh}$ , of PVSCs containing  $(\text{CsGA})_{15} + y\% \text{EDAl}_2$  with  $y = 0, 0.5, 1.0, 1.5,$  and  $2.0$  measured under AM 1.5G illumination obtained from the forward  $J$ – $V$  measurements

Device	$V_{oc}$ (V)	$J_{sc}$ ( $\text{mA cm}^{-2}$ )	FF	PCE (%)	$R_s$ ( $\Omega \text{ cm}^2$ )	$R_{sh}$ ( $\Omega \text{ cm}^2$ )
$(\text{CsGA})_{15} + 0\%$	$0.30 \pm 0.02$ (0.32)	$20.84 \pm 3.31$ (22.61)	$0.71 \pm 0.01$ (0.70)	$4.45 \pm 0.87$ (5.01)	2.40	64.46
$(\text{CsGA})_{15} + 0.5\%$	$0.35 \pm 0.02$ (0.35)	$21.43 \pm 2.28$ (24.03)	$0.61 \pm 0.04$ (0.63)	$4.58 \pm 0.61$ (5.39)	4.22	66.59
$(\text{CsGA})_{15} + 1.0\%$	$0.35 \pm 0.02$ (0.33)	$20.81 \pm 1.78$ (24.32)	$0.63 \pm 0.06$ (0.71)	$4.62 \pm 0.63$ (5.72)	2.72	78.00
$(\text{CsGA})_{15} + 1.5\%$	$0.38 \pm 0.01$ (0.36)	$20.23 \pm 1.18$ (21.16)	$0.66 \pm 0.06$ (0.75)	$5.05 \pm 0.53$ (5.69)	3.05	133.92
$(\text{CsGA})_{15} + 2.0\%$	$0.43 \pm 0.02$ (0.45)	$15.20 \pm 2.50$ (19.53)	$0.57 \pm 0.04$ (0.62)	$3.74 \pm 0.94$ (5.40)	6.67	92.14

the increased  $V_{oc}$  of 0.35 and 0.33 V, and  $J_{sc}$  of 24.03 and 24.32  $\text{mA cm}^{-2}$ , respectively. Adding 1.5% EDAl<sub>2</sub> further increases  $V_{oc}$  to 0.36 V and particularly increases the FF to 0.75, maintaining a high maximum PCE of 5.69%. The high FF may be due to the increasing Shunt resistance,  $R_{sh}$ , from 64.46  $\Omega \text{ cm}^2$  with 0% EDAl<sub>2</sub> to 133.92  $\Omega \text{ cm}^2$  with 1.5% EDAl<sub>2</sub>. When adding 2.0% EDAl<sub>2</sub>, although  $V_{oc}$  increases to the largest value of 0.45 V, the lowest  $J_{sc}$  of 19.53  $\text{mA cm}^{-2}$  and the FF of 0.62 decrease the maximum PCE slightly to 5.40%. The lowest  $J_{sc}$  may be due to an increase in series resistance,  $R_s$ , to the maximum of 6.67  $\Omega \text{ cm}^2$  among all  $(\text{CsGA})_{15}$  devices. Fig. 3c shows that the photocurrent at the maximum power point *versus* time for the  $(\text{CsGA})_{15} + 0$ –1.5% EDAl<sub>2</sub> devices remained stable under illumination in an inert atmosphere for the 10 min test period. The better performance exhibited by  $(\text{CsGA})_{15}$  devices with 0.5–1.5% EDAl<sub>2</sub> could be due to the benefits of improved film quality, (100) plane dominated termination, and reduced trap states. The declined performance of  $(\text{CsGA})_{15}$  with 2.0% EDAl<sub>2</sub> could be due to the rough surface, creating more interface trap states. PVSCs based on active layers of  $(\text{CsGA})_5$  and  $(\text{CsGA})_{10}$  with 0–2% EDAl<sub>2</sub> exhibit lower maximum PCEs compared to their counterparts of  $(\text{CsGA})_{15}$  mainly because of the lower  $J_{sc}$  and FF values. This could be attributed to the presence of more pinholes and impurity phases in the perovskite films, resulting in a higher  $R_s$  and lower  $R_{sh}$ .

A previous study has shown that devices based on  $\text{GA}_{0.20}\text{FA}_{0.80}\text{SnI}_3$  with 1% EDAl<sub>2</sub> active layers exhibited a  $V_{oc}$  of 0.619 V compared to 0.49 V for the devices based on  $\text{FASnI}_3$

with 1% EDAl<sub>2</sub> active layers because of the downshifted valence band maximum to  $-5.20$  eV *versus*  $-4.92$  eV, which aligns better with the work function of PEDOT:PSS ( $-5.2$  eV) as the HTL. The  $V_{oc}$  values of our devices are low compared to the reported  $V_{oc}$  values. To further investigate this, we conducted ultraviolet photoelectron spectroscopy (UPS) analysis of  $(\text{CsGA})_5$ ,  $(\text{CsGA})_{10}$  and  $(\text{CsGA})_{15}$  films with 1.5% EDAl<sub>2</sub> because the devices based on these films exhibit high performance. Fig. 4a shows the energy diagram of the materials involved in the devices. The valence band maxima (VBMs) of  $(\text{CsGA})_5$ ,  $(\text{CsGA})_{10}$  and  $(\text{CsGA})_{15}$  with 1.5% EDAl<sub>2</sub> were obtained from their UPS spectra (Fig. S8, ESI<sup>†</sup>) and the conduction band minima (CBMs) were estimated from the VBMs and the optical band gaps determined from the UV-Vis spectra of the  $(\text{CsGA})_5$ ,  $(\text{CsGA})_{10}$  and  $(\text{CsGA})_{15}$  films with 1.0% EDAl<sub>2</sub>. The VBMs are determined to be  $-5.08$ ,  $-5.07$  and  $-5.16$  eV for  $(\text{CsGA})_5$ ,  $(\text{CsGA})_{10}$  and  $(\text{CsGA})_{15}$  with 1.5% EDAl<sub>2</sub>, respectively. All of them are unfavorable for hole transport with the PEDOT:PSS HTL,<sup>15</sup> which could lead to low  $V_{oc}$  values. The deepest VBM and the smallest band gap of  $(\text{CsGA})_{15}$  make the CBM downshift to  $-3.73$  eV. Both the downshifted VBM and CBM of  $(\text{CsGA})_{15}$  enable the best energy alignment with the HTL and ETL, respectively, which could explain the best performance of devices based on  $(\text{CsGA})_{15}$  films. The  $(\text{CsGA})_5$ ,  $(\text{CsGA})_{10}$  and  $(\text{CsGA})_{15}$  films with 1.5% EDAl<sub>2</sub> have a Fermi level 0.4 eV above the VBM, indicating the p-type doping of all these perovskites (Fig. 4b). Previous studies have shown that guanidinium



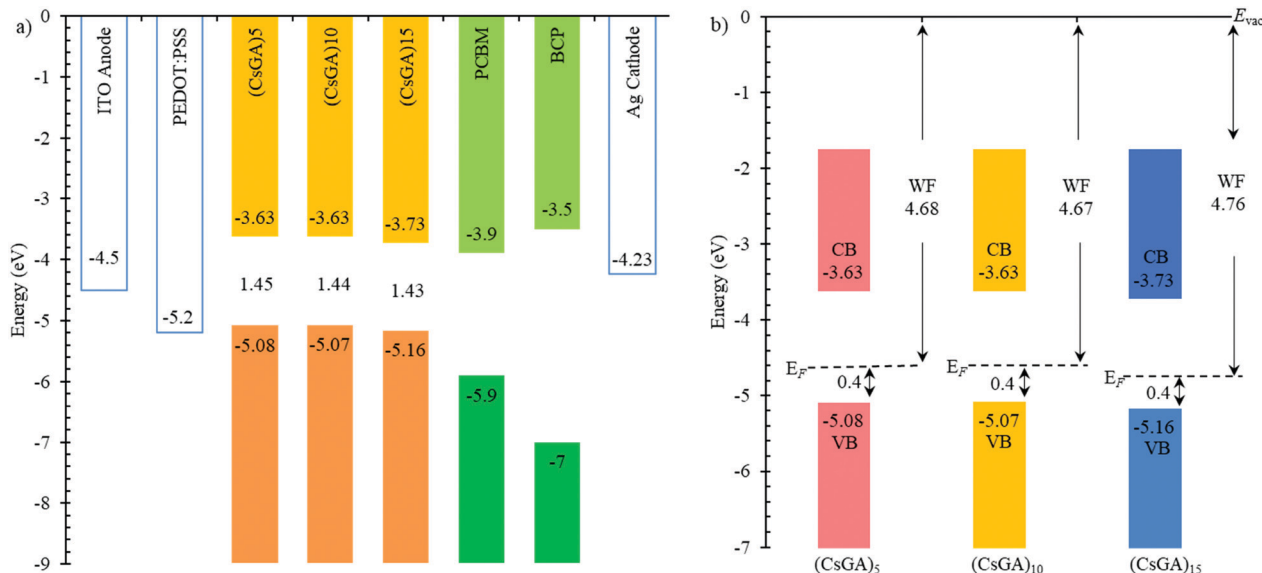


Fig. 4 (a) Band energy diagram of PVSCs with (CsGA)<sub>x</sub> + 1.5% EDAl<sub>2</sub> active layers, where  $x = 5, 10$  and  $15$ . The band gaps derived from the UV-Vis spectra are indicated. (b) Energy level scheme for the (CsGA)<sub>5</sub>, (CsGA)<sub>10</sub> and (CsGA)<sub>15</sub> films with 1.5% EDAl<sub>2</sub> based on the parameters derived from the UPS spectra.

addition in MAPbI<sub>3</sub> converts the perovskite to a p-type semiconductor with the Fermi level shifting from 1.1 to 0.89 eV above the VBM for MAPbI<sub>3</sub> and Ga<sub>0.25</sub>MA<sub>0.75</sub>PbI<sub>3</sub>, respectively.<sup>37</sup> X-site anion interstitial (X<sub>i</sub>), A-site and B-site vacancy (V<sub>A</sub> and V<sub>B</sub>), and antisite (A<sub>B</sub>, X<sub>A</sub> and X<sub>B</sub>) point defects typically lead to p-type perovskites.<sup>21</sup> Sn-based perovskites tend to be p-type due to self-doping by Sn<sup>4+</sup>.<sup>38</sup> The p-type nature of the (CsGA)<sub>15</sub> film with 1.5% EDAl<sub>2</sub> could be due to EDAl<sub>2</sub> having a “hollowing” impact on the perovskite structure, giving the increased lattice parameter (Fig. 2c). EDAl<sub>2</sub> has been shown to favor replacing octahedral cages with the B-site and the X-site and these metal and halide defects (vacancies and antisites) contribute to a more p-type perovskite.<sup>19,29,39</sup> Since the lattice parameters of (CsGA)<sub>5</sub> and (CsGA)<sub>10</sub> films with 1.5% EDAl<sub>2</sub> are even smaller than those without EDAl<sub>2</sub> because of the possibility of expelling GA<sup>+</sup> cations, A-site vacancies could be formed in these perovskites besides the aforementioned point defects, resulting in p-type perovskites.

Balanced charge generation, recombination and extraction rates are key factors in determining solar cell performance.<sup>40</sup> Charge recombination results in loss of photogenerated charges, lowering  $J_{sc}$  and FF. The maximum  $V_{oc}$  of a solar cell can be achieved when all photogenerated charges recombine solely radiatively.<sup>41</sup> To understand device performance related to the mitigation of defects by incorporating EDAl<sub>2</sub> in (CsGA)<sub>15</sub> perovskites, we investigated the evolution of  $V_{oc}$ ,  $J_{sc}$  and FF as a function of light intensity for (CsGA)<sub>15</sub> with 0–1.5% EDAl<sub>2</sub>. The  $V_{oc}$  of light intensity is an independent exploration of recombination compared to that of  $J_{sc}$  and FF. The current is zero under open-circuit conditions with all photogenerated carriers recombining within the cell. Recombination studies near the open-circuit are, therefore, particularly sensitive to recombination mechanisms and the impact of shallow traps. The open-circuit

voltage shows a logarithmic dependence on light intensity with a slope of  $nk_B T/q$ , where  $n$  represents different recombination mechanisms,  $k_B$  is the Boltzmann constant,  $T$  is the absolute temperature, and  $q$  is the elementary charge. When  $n > 2$ , monomolecular recombination dominates and trap states play a significant role, while when  $n \sim 1$ , bimolecular recombination dominates, demonstrating minimal shallow trap states in the perovskites.<sup>42</sup> The  $V_{oc}$  versus logarithmic scale light intensity plots for (CsGA)<sub>15</sub> devices show that the slope changes from greater than 2 to close to 1 from no EDAl<sub>2</sub> addition to 1.0 and 1.5% EDAl<sub>2</sub> addition (Fig. 5a), indicating charge carrier recombination from monomolecular, trap-state assisted recombination to bimolecular recombination. These results are consistent with the trap-state reduction shown by the UV-Vis and PL spectra, which further supports the hypothesis that EDAl<sub>2</sub> has a hollowing effect, reducing bulk defects.

Fig. 5b shows the double logarithmic scale with the relation of  $J_{sc}$  versus light intensity. For the power law dependence of  $J_{sc}$  on light intensity ( $J_{sc} \propto I^\alpha$ ), the deviation from unity of the slope implies bimolecular recombination. When  $\alpha$  is less than 1, this could be a result of bimolecular recombination, variations in both carrier mobilities, or distribution in the density of states. When  $\alpha \sim 0.75$ , space charge effects might be induced by the interfacial layers. When  $\alpha = 1$ , there are no space charge effects and all carriers are swept out prior to recombination.<sup>42,43</sup> For EDAl<sub>2</sub> addition from 0% to 1.5%,  $\alpha$  values change from 1.21 to 1.00. This shows that the addition of EDAl<sub>2</sub> reduces the deep trap states by passivating grain boundaries and charge carriers are effectively extracted. We also plotted FF as a function of logarithmic scale light intensity (Fig. 5c). These FF trends show the different capabilities of the perovskite materials to support balanced charge carrier generation and extraction over this range of light intensities.





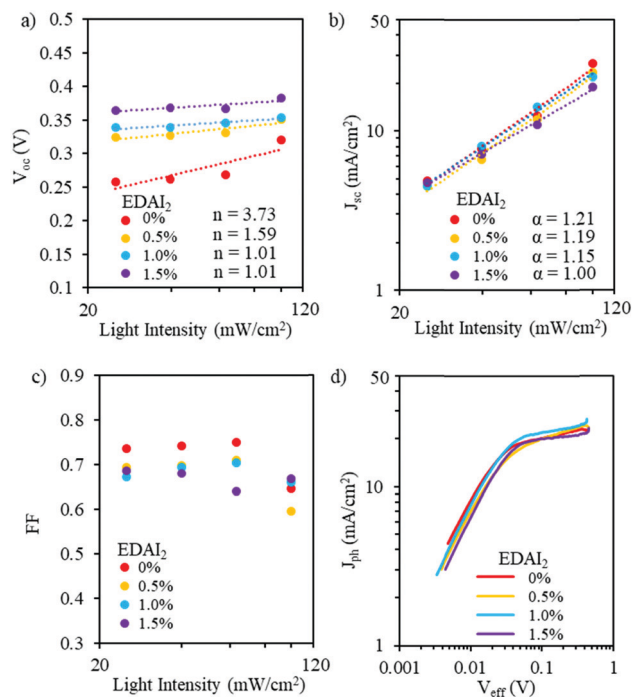


Fig. 5 (a)  $V_{oc}$ , (b)  $J_{sc}$ , and (c) FF as a function of light intensity and (d) photocurrent density as a function of effective voltage for PVSCs with (CsGA)<sub>15</sub> + 0–1.5% EDAl<sub>2</sub>.

At low light intensities, the (CsGA)<sub>15</sub> device without EDAl<sub>2</sub> shows a higher FF compared to the devices with 0.5–1.5% EDAl<sub>2</sub>, indicating that, despite the trap states, low density

charge carriers in (CsGA)<sub>15</sub> + 0% EDAl<sub>2</sub> are still able to be extracted due to the high intrinsic charge carrier mobility and long diffusion length of perovskites.<sup>44,45</sup> When the light intensity increases to 1 sun, 100 mW cm<sup>-2</sup>, more charge carriers are recombined *via* trap states, leading to a significant decrease of FF for (CsGA)<sub>15</sub> with 0 and 0.5% EDAl<sub>2</sub>. The (CsGA)<sub>15</sub> device with 1.5% EDAl<sub>2</sub> retains the same level of FF at 1 sun illumination, demonstrating the reduction of trap states by adding EDAl<sub>2</sub>. To elucidate whether the FF reduction under 1 sun illumination for the (CsGA)<sub>15</sub> devices without EDAl<sub>2</sub> and those with 0.5–1% EDAl<sub>2</sub> is due to the charge extraction limit, we explored the photocurrent density ( $J_{ph}$ ) as a function of effective voltage ( $V_{eff}$ ).  $J_{ph}$  is defined as  $J_{ph} = J_1 - J_d$ , where  $J_1$  and  $J_d$  represent the current densities under light and dark conditions, respectively.  $V_{eff}$  is defined as  $V_{eff} = V_0 - V$ , where  $V_0$  is the compensation voltage defined as  $J_{ph}(V_0) = 0$  and  $V$  is the applied voltage.<sup>40</sup> Fig. 5d shows that, for all devices, photocurrent densities under 1 sun illumination reach saturation at a similar low effective voltage  $\sim 0.05$  V, suggesting that charge extraction is not a limiting factor. The low saturation effective voltage could be linked to the better band alignment of (CsGA)<sub>15</sub> with the charge selective layers (Fig. 4a).

To determine the impact of mixing CsGA with FA at the A-site and adding EDAl<sub>2</sub> on the stability of pure Sn perovskite solar cells, long-term device stability in an inert environment was evaluated. Fig. 6 shows the normalized  $V_{oc}$ ,  $J_{sc}$ , FF, and PCE of (CsGA)<sub>15</sub> + 0–1.5% EDAl<sub>2</sub> devices over 45 days in an inert nitrogen atmosphere. The devices with 0% EDAl<sub>2</sub> show a decrease of all photovoltaic parameters over time and after 30 days show a short-circuited behavior. This short-circuited

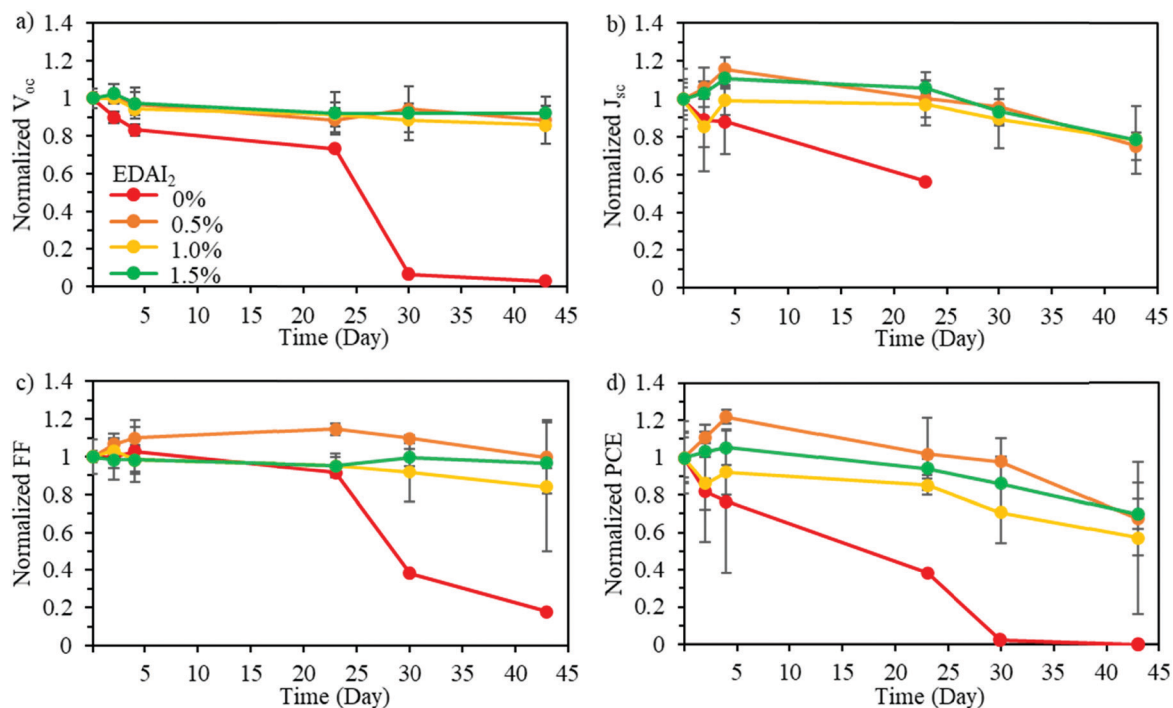


Fig. 6 Normalized (a)  $V_{oc}$ , (b)  $J_{sc}$ , (c) FF, and (d) PCE of the devices containing the active layers of (CsGA)<sub>15</sub> + 0–1.5% EDAl<sub>2</sub> over time in a nitrogen-filled glove box. The (CsGA)<sub>15</sub> + 0% EDAl<sub>2</sub> devices showed a short-circuited behavior after 30 days.



behavior is due to highly oxidized  $\text{Sn}^{4+}$ , which has been shown to create metal-like conductivity in perovskite solar cells.<sup>46</sup> The addition of  $\text{EDAI}_2$  greatly increased the device stability, further demonstrating the point defect reducing capability of  $\text{EDAI}_2$  by hollowing crystal structures and passivating grain boundaries. In the case of 0.5–1.5%  $\text{EDAI}_2$  addition, Fig. 6 shows that  $V_{oc}$  is very stable while  $J_{sc}$  and FF briefly increase during storage. The performance of the  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  device with 1.5%  $\text{EDAI}_2$  shows an increase in maximum PCE from 5.69% to 6.39% after 5 days of storage. Previously, with  $\text{GA}_{0.2}\text{FA}_{0.8}\text{SnI}_3$  perovskite films and 1%  $\text{EDAI}_2$ , the efficiency also increased in storage as well.<sup>15</sup> Since this phenomenon only occurs with  $\text{EDAI}_2$  addition in our research and mostly impacts  $J_{sc}$ , this shows that there is an increased amount of grain passivation over time.  $\text{EDAI}_2$  is successfully able to prevent oxidation, maintaining these photovoltaic parameters.

## Conclusion

In summary, the addition of  $\text{Cs}^+$  and  $\text{GA}^+$  into  $\text{FASnI}_3$  was implemented to utilize the high hydrogen bonding capability of the  $\text{GA}^+$  organic cation while relaxing the local lattice strain and filling point defects with a smaller  $\text{Cs}^+$  counter cation. The  $\text{EDAI}_2$  additive not only yielded pinhole-free cubic phase  $(\text{CsGA})_x\text{FA}_{1-2x}\text{SnI}_3$  perovskite films but also decreased both shallow and deep trap states in the perovskite films. With increased CsGA substitution, the relaxed strain allowed more integration of  $\text{EDAI}_2$  into the crystal structure, increasing these positive impacts. The devices with  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  and 0–2%  $\text{EDAI}_2$  all achieved a maximum PCE higher than 5% with the highest of 5.72% for a fresh device with  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  and 1%  $\text{EDAI}_2$ . After storage, the maximum PCE was increased from 5.69% to 6.39% for the  $(\text{CsGA})_{0.15}\text{FA}_{0.70}\text{SnI}_3$  and 1.5%  $\text{EDAI}_2$  devices. The devices with the  $\text{EDAI}_2$  additive showed better long-term stability compared to those without  $\text{EDAI}_2$ . Overall, this study demonstrates cation tuning to integrate stabilizing factors into pure Sn perovskites, creating potential routes for further improving lead-free devices in the future.

## Conflicts of interest

The authors declare no conflict of interest.

## Acknowledgements

This work was supported by the National Science Foundation (NSF) (CBET-1748101 and CMMI-1661660) and the Defense Threat Reduction Agency (HDTRA 1-15-1-0021). GAT acknowledges the support from the NSF Graduate Research Fellowship Program Fellowship and the University of Washington (UW) Clean Energy Institute (CEI) Graduate Research and Education Fellowships funded by the State of Washington via the Washington Research Foundation. Part of this work was conducted at the Molecular Analysis Facility, a National Nanotechnology Coordinated Infrastructure site at the UW, which is

supported in part by the NSF (ECC-1542101), the UW, the Molecular Engineering & Sciences Institute, the CEI, and the National Institutes of Health. Some device fabrications and evaluations were carried out in the UW Department of Chemistry's Photonics Research Center. UV-Vis-NIR absorption measurements were carried out in the UW Department of Chemistry's Spectroscopic and Analytical Instrumentation facility.

## References

- 1 NREL, Best Research-Cell Efficiency Chart, <https://www.nrel.gov/pv/cell-efficiency.html>.
- 2 Q. Chen, N. De Marco, Y. Yang, T. Bin Song, C. C. Chen, H. Zhao, Z. Hong, H. Zhou and Y. Yang, *Nano Today*, 2015, **10**, 355–396.
- 3 S. Chatterjee and A. J. Pal, *J. Mater. Chem. A*, 2018, **6**, 3793–3823.
- 4 G. Nasti and A. Abate, *Adv. Energy Mater.*, 2019, **13**, 1–16.
- 5 H. Yao, F. Zhou, Z. Li, Z. Ci, L. Ding and Z. Jin, *Adv. Sci.*, 2020, 1903540.
- 6 K. Liang, D. B. Mitzi and M. T. Prikas, *Chem. Mater.*, 1998, **10**, 403–411.
- 7 T. Leijtens, R. Prasanna, A. Gold-Parker, M. F. Toney and M. D. McGehee, *ACS Energy Lett.*, 2017, **2**, 2159–2165.
- 8 W. Ke and M. G. Kanatzidis, *Nat. Commun.*, 2019, **10**, 1–4.
- 9 C. C. Stoumpos, C. D. Malliakas and M. G. Kanatzidis, *Inorg. Chem.*, 2013, **52**, 9019–9038.
- 10 M. Konstantakou and T. Stergiopoulos, *J. Mater. Chem. A*, 2017, **5**, 11518–11549.
- 11 Z. Chen, C. Yu, K. Shum, J. J. Wang, W. Pfenninger, N. Vockic, J. Midgley and J. T. Kenney, *J. Lumin.*, 2012, **132**, 345–349.
- 12 N. K. Noel, S. D. Stranks, A. Abate, C. Wehrenfennig, S. Guarnera, A. A. Haghghirad, A. Sadhanala, G. E. Eperon, S. K. Pathak, M. B. Johnston, A. Petrozza, L. M. Herz and H. J. Snaith, *Energy Environ. Sci.*, 2014, **7**, 3061–3068.
- 13 F. Hao, C. C. Stoumpos, D. H. Cao, R. P. H. Chang and M. G. Kanatzidis, *Nat. Photonics*, 2014, **8**, 489–494.
- 14 W. Liao, D. Zhao, Y. Yu, C. R. Grice, C. Wang, A. J. Cimaroli, P. Schulz, W. Meng, K. Zhu, R. G. Xiong and Y. Yan, *Adv. Mater.*, 2016, **28**, 9333–9340.
- 15 E. Jokar, C. H. Chien, C. M. Tsai, A. Fathi and E. W. G. Diau, *Adv. Mater.*, 2019, **31**, 1–7.
- 16 S. Kanno, Y. Imamura and M. Hada, *J. Phys. Chem. C*, 2018, **122**, 15966–15972.
- 17 N. De Marco, H. Zhou, Q. Chen, P. Sun, Z. Liu, L. Meng, E. P. Yao, Y. Liu, A. Schiffer and Y. Yang, *Nano Lett.*, 2016, **16**, 1009–1016.
- 18 M. I. Saidaminov, J. Kim, A. Jain, R. Quintero-Bermudez, H. Tan, G. Long, F. Tan, A. Johnston, Y. Zhao, O. Voznyy and E. H. Sargent, *Nat. Energy*, 2018, **3**, 648–654.
- 19 W. Ke, C. C. Stoumpos, M. Zhu, L. Mao, I. Spanopoulos, J. Liu, O. Y. Kontsevoi, M. Chen, D. Sarma, Y. Zhang,



- M. R. Wasielewski and M. G. Kanatzidis, *Sci. Adv.*, 2017, **3**, 1–10.
- 20 Z. Ni, C. Bao, Y. Liu, Q. Jiang, W. Q. Wu, S. Chen, X. Dai, B. Chen, B. Hartweg, Z. Yu, Z. Holman and J. Huang, *Science*, 2020, **367**, 1352–1358.
- 21 H. Jin, E. Debroye, M. Keshavarz, I. G. Scheblykin, M. B. J. Roeffaers, J. Hofkens and J. A. Steele, *Mater. Horiz.*, 2020, **7**, 397–410.
- 22 I. Spanopoulos, W. Ke, C. C. Stoumpos, E. C. Schueller, O. Y. Kontsevoi, R. Seshadri and M. G. Kanatzidis, *J. Am. Chem. Soc.*, 2018, **140**, 5728–5742.
- 23 E. Jokar, C. H. Chien, A. Fathi, M. Rameez, Y. H. Chang and E. W. G. Diau, *Energy Environ. Sci.*, 2018, **11**, 2353–2362.
- 24 S. J. Lee, S. S. Shin, Y. C. Kim, D. Kim, T. K. Ahn, J. H. Noh, J. Seo and S. Il Seok, *J. Am. Chem. Soc.*, 2016, **138**, 3974–3977.
- 25 T. Bin Song, T. Yokoyama, S. Aramaki and M. G. Kanatzidis, *ACS Energy Lett.*, 2017, **2**, 897–903.
- 26 T. Wang and F. Yan, *Chem. – Asian J.*, 2020, **15**, 1524–1535.
- 27 Z. Zhu, C. C. Chueh, N. Li, C. Mao and A. K. Y. Jen, *Adv. Mater.*, 2018, **30**, 1–9.
- 28 Q. Q. Ge, J. Ding, J. Liu, J. Y. Ma, Y. X. Chen, X. X. Gao, L. J. Wan and J. S. Hu, *J. Mater. Chem. A*, 2016, **4**, 13458–13467.
- 29 W. Ke, I. Spanopoulos, Q. Tu, I. Hadar, X. Li, G. S. Shekhawat, V. P. Dravid and M. G. Kanatzidis, *J. Am. Chem. Soc.*, 2019, **141**, 8627–8637.
- 30 D. J. Kubicki, D. Prochowicz, A. Hofstetter, M. Saski, P. Yadav, D. Bi, N. Pellet, J. Lewiński, S. M. Zakeeruddin, M. Grätzel and L. Emsley, *J. Am. Chem. Soc.*, 2018, **140**, 3345–3351.
- 31 W. Zhang, J. Xiong, J. Li and W. A. Daoud, *J. Mater. Chem. A*, 2019, **7**, 9486–9496.
- 32 K. Huang, L. Yuan and S. Feng, *Inorg. Chem. Front.*, 2015, **2**, 965–981.
- 33 G. A. Tosado, Y. Y. Lin, E. Zheng and Q. Yu, *J. Mater. Chem. A*, 2018, **6**, 17426–17436.
- 34 J. H. Lee, N. C. Bristowe, J. H. Lee, S. H. Lee, P. D. Bristowe, A. K. Cheetham and H. M. Jang, *Chem. Mater.*, 2016, **28**, 4259–4266.
- 35 R. Prasanna, A. Gold-Parker, T. Leijtens, B. Conings, A. Babayigit, H. G. Boyen, M. F. Toney and M. D. McGehee, *J. Am. Chem. Soc.*, 2017, **139**, 11117–11124.
- 36 Y. Shao, Z. Xiao, C. Bi, Y. Yuan and J. Huang, *Nat. Commun.*, 2014, **5**, 1–7.
- 37 D. Prochowicz, M. M. Tavakoli, A. Q. Alanazi, S. Trivedi, H. Tavakoli Dastjerdi, S. M. Zakeeruddin, M. Grätzel and P. Yadav, *ACS Omega*, 2019, **4**, 16840–16846.
- 38 E. W. G. Diau, E. Jokar and M. Rameez, *ACS Energy Lett.*, 2019, **4**, 1930–1937.
- 39 W. Ke, C. C. Stoumpos, I. Spanopoulos, L. Mao, M. Chen, M. R. Wasielewski and M. G. Kanatzidis, *J. Am. Chem. Soc.*, 2017, **139**, 14800–14806.
- 40 J. Troughton, N. Gasparini and D. Baran, *J. Mater. Chem. A*, 2018, **6**, 21913–21917.
- 41 W. Shockley and H. J. Queisser, *J. Appl. Phys.*, 1961, **32**, 510–519.
- 42 S. R. Cowan, A. Roy and A. J. Heeger, *Phys. Rev. B: Condens. Matter Mater. Phys.*, 2010, **82**, 1–10.
- 43 S. Shao, Z. Chen, H. H. Fang, G. H. Ten Brink, D. Bartesaghi, S. Adjokatse, L. J. A. Koster, B. J. Kooi, A. Facchetti and M. A. Loi, *J. Mater. Chem. A*, 2016, **4**, 2419–2426.
- 44 L. M. Herz, *ACS Energy Lett.*, 2017, **2**, 1539–1548.
- 45 S. D. Stranks, G. E. Eperon, G. Grancini, C. Menelaou, M. J. P. Alcocer, T. Leijtens, L. M. Herz, A. Petrozza and H. J. Snaith, *Science*, 2013, **342**, 341–345.
- 46 I. Chung, J. H. Song, J. Im, J. Androulakis, C. D. Malliakas, H. Li, A. J. Freeman, J. T. Kenney and M. G. Kanatzidis, *J. Am. Chem. Soc.*, 2012, **134**, 8579–8587.

